



INA115

Precision INSTRUMENTATION AMPLIFIER

FEATURES

- LOW OFFSET VOLTAGE: 50µV max
- LOW DRIFT: 0.25μV/°C max
- LOW INPUT BIAS CURRENT: 2nA max
- HIGH COMMON-MODE REJECTION: 115dB min
- INPUT OVER-VOLTAGE PROTECTION: ±40V
- WIDE SUPPLY RANGE: ±2.25 TO ±18V
- LOW QUIESCENT CURRENT: 3mA max
- SOL-16 SURFACE-MOUNT PACKAGE

APPLICATIONS

- SWITCHED-GAIN AMPLIFIER
- BRIDGE AMPLIFIER
- THERMOCOUPLE AMPLIFIER
- RTD SENSOR AMPLIFIER
- MEDICAL INSTRUMENTATION
- DATA ACQUISITION

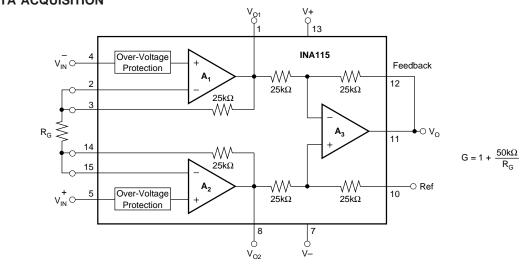
DESCRIPTION

The INA115 is a low cost, general purpose instrumentation amplifier offering excellent accuracy. Its versatile three-op amp design and small size make it ideal for a wide range of applications. Similar to the model INA114, the INA115 provides additional connections to the input op amps, A_1 and A_2 , which improve gain accuracy in high gains and are useful in forming switched-gain amplifiers.

A single external resistor sets any gain from 1 to 10,000. Internal input protection can withstand up to $\pm 40V$ without damage.

The INA115 is laser trimmed for very low offset voltage (50 μ V), drift (0.25 μ V/°C) and high commonmode rejection (115dB at G=1000). It operates with power supplies as low as ±2.25V, allowing use in battery operated and single 5V supply systems. Quiescent current is 3mA maximum.

The INA115 is available in the SOL-16 surface-mount package, specified for the -40° C to $+85^{\circ}$ C temperature range.



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SPECIFICATIONS

ELECTRICAL

At $T_A = +25^{\circ}C$, $V_S = \pm 15V$, $R_L = 2k\Omega$ unless otherwise noted.

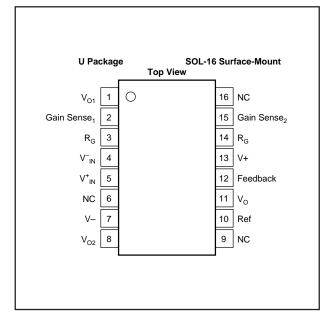
		INA115BU				INA115AU		
PARAMETER	CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
INPUT Offset Voltage, RTI Initial vs Temperature vs Power Supply Long-Term Stability Impedance, Differential Common-Mode Input Common-Mode Range	$T_A = +25^{\circ}C$ $T_A = T_{MIN} \text{ to } T_{MAX}$ $V_S = \pm 2.25V \text{ to } \pm 18V$	±11	$\begin{array}{c} \pm 10 + 20/G\\ \pm 0.1 + 0.5/G\\ 0.5 + 2/G\\ \pm 0.2 + 0.5/G\\ 10^{10} \parallel 6\\ 10^{10} \parallel 6\\ \pm 13.5 \end{array}$	±50 + 100/G ±0.25 + 5/G 3 + 10/G	*	±25 + 30/G ±0.25 + 5/G * * *	±125 + 500/G ±1 + 10/G *	μV μV/°C μV/ν μV/mo Ω pF Ω pF V
Safe Input Voltage Common-Mode Rejection	$\begin{array}{l} V_{CM} = \pm 10V, \Delta R_{S} = 1 k \Omega \\ G = 1 \\ G = 10 \\ G = 100 \\ G = 1000 \end{array}$	80 96 110 115	96 115 120 120	±40	75 90 106 106	90 106 110 110	*	V dB dB dB dB
BIAS CURRENT vs Temperature			±0.5 ±8	±2		* *	±5	nA pA/°C
OFFSET CURRENT vs Temperature			±0.5 ±8	±2		* *	±5	nA pA/°C
NOISE VOLTAGE, RTI f = 10Hz f = 100Hz f = 1kHz f _g = 0.1Hz to 10Hz Noise Current f=10Hz	G = 1000, R _S = 0Ω		15 11 11 0.4 0.4			* * * * *		nV/√Hz nV/√Hz nV/√Hz μVp-p pA/√Hz
f=1kHz f _B = 0.1Hz to 10Hz			0.2 18			* *		pA/√Hz pAp-p
GAIN Gain Equation Range of Gain Gain Error Gain vs Temperature 50kΩ Resistance ⁽¹⁾ Nonlinearity	G = 1G = 10G = 100G = 1000G = 1G = 1G = 10G = 100G = 1000	1	$\begin{array}{c} 1 + (50 k \Omega / R_G) \\ \pm 0.01 \\ \pm 0.02 \\ \pm 0.05 \\ \pm 2.5 \\ \pm 2.5 \\ \pm 0.0001 \\ \pm 0.0005 \\ \pm 0.0005 \\ \pm 0.002 \end{array}$	$\begin{array}{c} 10000\\ \pm 0.05\\ \pm 0.4\\ \pm 0.5\\ \pm 1\\ \pm 10\\ \pm 100\\ \pm 0.001\\ \pm 0.002\\ \pm 0.002\\ \pm 0.01\end{array}$	*	* *****	* ±0.5 ±0.7 ±2 ±10 * ±0.002 ±0.004 ±0.004 ±0.02	V/V V/V % % % ppm/°C ppm/°C % of FSR % of FSR % of FSR % of FSR
OUTPUT ⁽²⁾ Voltage Load Capacitance Stability Short Circuit Current	$\label{eq:loss} \begin{array}{l} I_{O}=5\text{mA}, \ T_{\text{MIN}} \ \text{to} \ T_{\text{MAX}} \\ V_{S}=\pm11.4\text{V}, \ R_{L}=2k\Omega \\ V_{S}=\pm2.25\text{V}, \ R_{L}=2k\Omega \end{array}$	±13.5 ±10 ±1	±13.7 ±10.5 ±1.5 1000 +20/-15		* * *	* * * * *		V V PF mA
FREQUENCY RESPONSE Bandwidth, –3dB Slew Rate Settling Time, 0.01% Overload Recovery	$\begin{array}{c} G = 1 \\ G = 10 \\ G = 100 \\ G = 1000 \\ V_{O} = \pm 10V, \ G = 10 \\ G = 1 \\ G = 10 \\ G = 100 \\ G = 1000 \\ 50\% \ \text{Overdrive} \end{array}$	0.3	1 100 10 1 0.6 18 20 120 1100 20		*	* * * * * * * *		MHz kHz kHz μs μs μs μs μs μs
POWER SUPPLY Voltage Range Current	V _{IN} = 0V	±2.25	±15 ±2.2	±18 ±3	*	* *	* *	V mA
TEMPERATURE RANGE Specification Operating θ_{JA}		-40 -40	80	+85 +125	* *	*	* *	°C ℃ W\2°

* Specification same as INA115BU.

NOTE: (1) Temperature coefficient of the " $50k\Omega$ " term in the gain equation. (2) Output specifications are for output amplifier, A₃. A₁ and A₂ provide the same output voltage swing but have less output current drive. A₁ and A₂ can drive external loads of $25k\Omega \parallel 200$ pF.



PIN CONFIGURATIONS



PACKAGE/ORDERING INFORMATION

PRODUCT	PACKAGE	PACKAGE DRAWING NUMBER ⁽¹⁾	TEMPERATURE RANGE
	SOL-16 Surface-Mount SOL-16 Surface-Mount		-40°C to +85°C -40°C to +85°C

NOTE: (1) For detailed drawing and dimension table, please see end of data sheet, or Appendix C of Burr-Brown IC Data Book.

ELECTROSTATIC DISCHARGE SENSITIVITY

This integrated circuit can be damaged by ESD. Burr-Brown recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ABSOLUTE MAXIMUM RATINGS

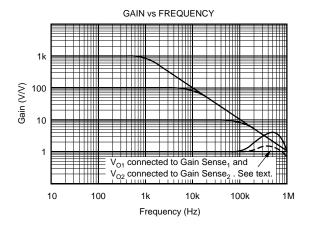
Supply Voltage	+19\/
Input Voltage Range	±40V
Output Short-Circuit (to ground)	Continuous
Operating Temperature	40°C to +125°C
Storage Temperature	40°C to +125°C
Junction Temperature	+150°C
Lead Temperature (soldering, 10s)	

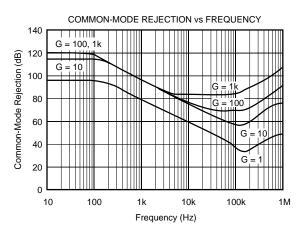
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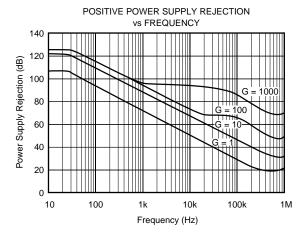
TYPICAL PERFORMANCE CURVES

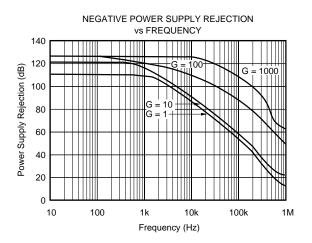
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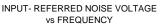


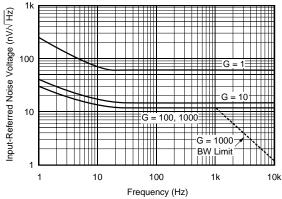


INPUT COMMON-MODE VOLTAGE RANGE vs OUTPUT VOLTAGE 15 Limited by A1 Limited by A Output Swing Output Swing 10 Common-Mode Voltage (V) V_{D/2} Ł 5 0 Ē V_{CM} (Any Gain) A₃ – Output A₃ + Output 🗡 -5 Swing Limit Swing Limit Limited by A2 Limited by A1 Output Swing -10 Output Swing -15 5 -15 -10 -5 0 10 15 Output Voltage (V)





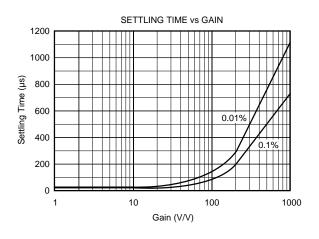


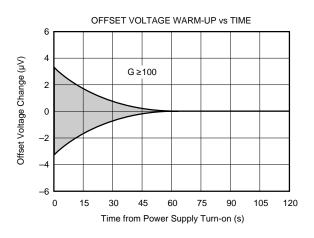




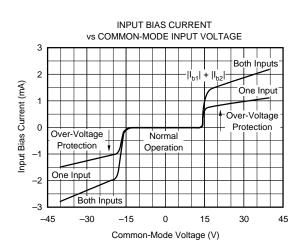
TYPICAL PERFORMANCE CURVES (CONT)

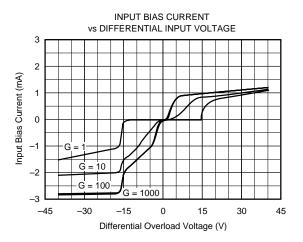
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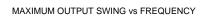


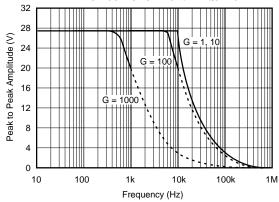


INPUT BIAS AND INPUT OFFSET CURRENT vs TEMPERATURE 2 Input Bias and Input Offset Current (nA) 1 ±ا 0 05 -1 -2 60 85 -40 -15 10 35 Temperature (°C)





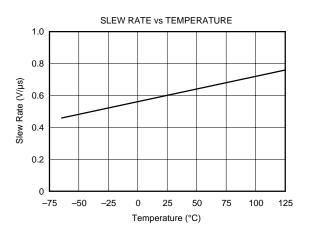


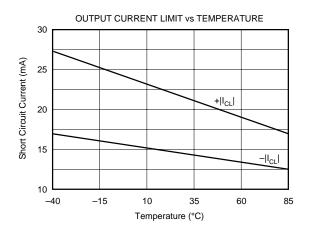


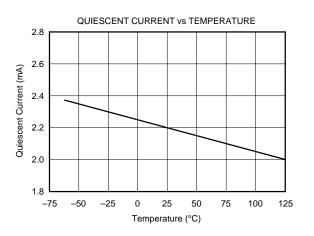


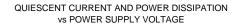
TYPICAL PERFORMANCE CURVES (CONT)

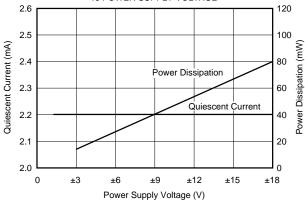
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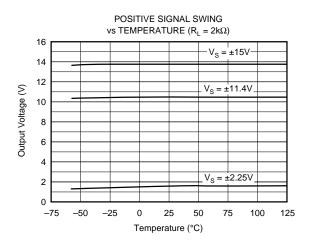


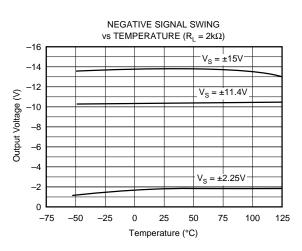








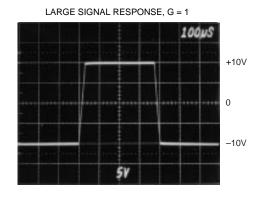


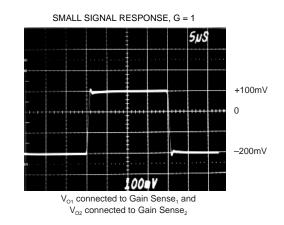




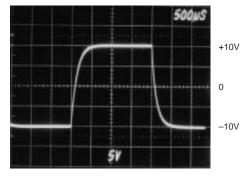
TYPICAL PERFORMANCE CURVES (CONT)

At $\rm T_{A}$ = +25°C, $\rm V_{S}$ = ±15V, unless otherwise noted.

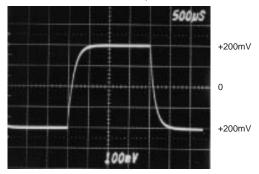




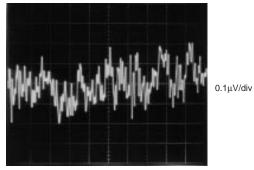
LARGE SIGNAL RESPONSE, G = 1000



SMALL SIGNAL RESPONSE, G = 1000



INPUT-REFERRED NOISE, 0.1 to 10Hz



1 s/div





APPLICATION INFORMATION

Figure 1 shows the basic connections required for operation of the INA115. Applications with noisy or high impedance power supplies may require decoupling capacitors close to the device pins as shown.

The output is referred to the output reference (Ref) terminal which is normally grounded. This must be a low-impedance connection to assure good common-mode rejection. A resistance of 5Ω in series with the Ref pin will cause a typical device to degrade to approximately 80dB CMR (G=1).

The INA115 has a separate output sense feedback connection (pin 12). Pin 12 must be connected (normally to the output terminal, pin 11) for proper operation. The output sense connection can be used to sense the output voltage directly at the load for best accuracy.

SETTING THE GAIN

Gain of the INA115 is set by connecting a single external resistor, R_c :

$$G = 1 + \frac{50 \text{ k}\Omega}{R_{G}} \tag{1}$$

Commonly used gains and resistor values are shown in Figure 1.

For G=1, no resistor is required, but connect pins 2-3 and connect pins 14-15. Gain peaking in G=1 can be reduced by shorting the internal $25k\Omega$ feedback resistors (see typical performance curve Gain vs Frequency). To do this, connect pins 1-2-3 and connect pins 8-14-15.

The 50k Ω term in equation 1 comes from the sum of the two internal feedback resistors. These are on-chip metal film resistors which are laser trimmed to accurate absolute values. The accuracy and temperature coefficient of these resistors are included in the gain accuracy and drift specifications of the INA115.

The stability and temperature drift of the external gain setting resistor, R_{g} , also affects gain. R_{g} 's contribution to gain error and drift can be directly inferred from the gain equation (1). Low resistor values required for high gain can make wiring resistance important. The "force and sense" type connections illustrated in Figure 1 help reduce the effect of interconnection resistance.

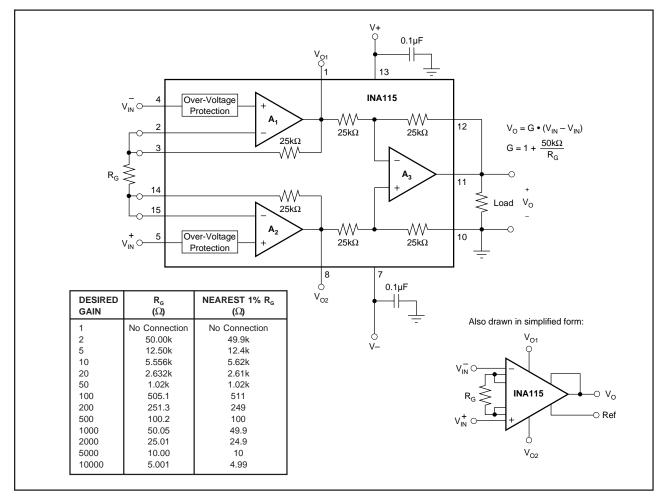


FIGURE 1. Basic Connections.



SWITCHED GAIN

Figure 2 shows a circuit for digital selection of four gains. Multiplexer "on" resistance does not significantly affect gain. The resistor values required for some commonly used gain steps are shown. This circuit uses the internal $25k\Omega$ feedback resistors, so the resistor values shown cannot be scaled to a different impedance level.

Figure 3 shows an alternative switchable gain configuration. This circuit does not use the internal $25k\Omega$ feedback resistors, so the nominal values shown can be scaled to other impedance levels. This circuit is ideal for use with a precision resistor network to achieve excellent gain accuracy and lowest gain drift.

NOISE PERFORMANCE

The INA115 provides very low noise in most applications. For differential source impedances less than $1k\Omega$, the INA103 may provide lower noise. For source impedances greater than $50k\Omega$, the INA111 FET-Input Instrumentation Amplifier may provide lower noise.

Low frequency noise of the INA115 is approximately 0.4μ Vp-p measured from 0.1 to 10Hz. This is approximately one-tenth the noise of "low noise" chopper-stabilized amplifiers.

OFFSET TRIMMING

The INA115 is laser trimmed for very low offset voltage and drift. Most applications require no external offset adjustment. Figure 4 shows an optional circuit for trimming the output offset voltage. The voltage applied to Ref terminal is summed at the output. Low impedance must be maintained at this node to assure good common-mode rejection. This is achieved by buffering the trim voltage with an op amp as shown.

INPUT BIAS CURRENT RETURN PATH

The input impedance of the INA115 is extremely high approximately $10^{10}\Omega$. However, a path must be provided for the input bias current of both inputs. This input bias current is typically less than ± 1 nA (it can be either polarity due to cancellation circuitry). High input impedance means that this input bias current changes very little with varying input voltage.

Input circuitry must provide a path for this input bias current if the INA115 is to operate properly. Figure 5 shows various provisions for an input bias current path. Without a bias current return path, the inputs will float to a potential which exceeds the common-mode range of the INA115 and the input amplifiers will saturate. If the differential source resistance is low, a bias current return path can be connected to one input (see thermocouple example in Figure 5). With higher source impedance, using two resistors provides a balanced input with possible advantages of lower input offset voltage due bias current and better common-mode rejection.

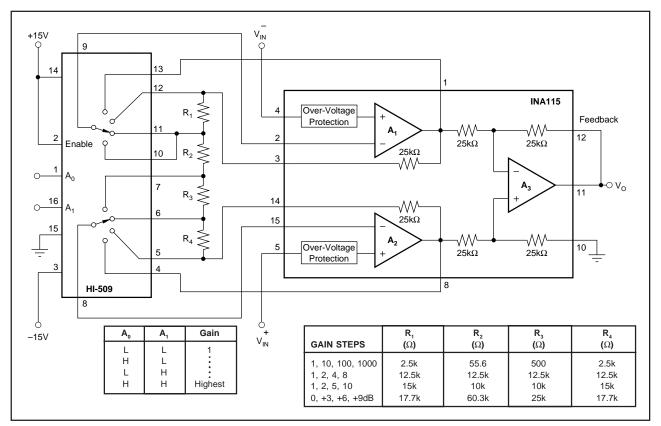


FIGURE 2. Switched-Gain Instrumentation Amplifier (minimum components).



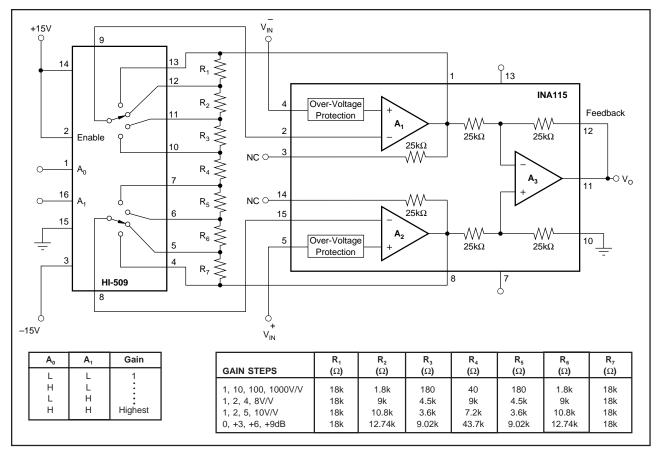


FIGURE 3. Switched-Gain Instrumentation Amplifier (improved gain drift).

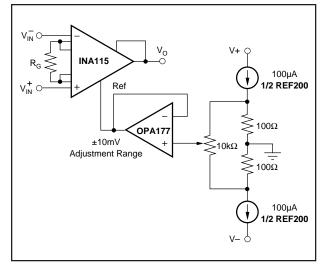


FIGURE 4. Optional Trimming of Output Offset Voltage.

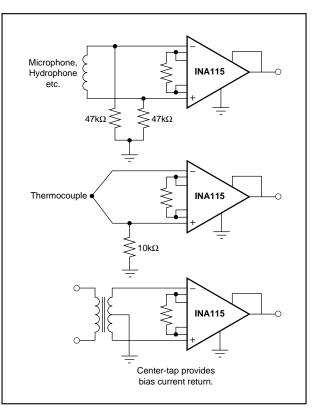


FIGURE 5. Providing an Input Common-Mode Current Path.



INPUT COMMON-MODE RANGE

The linear common-mode range of the input op amps of the INA115 is approximately $\pm 13.75V$ (or 1.25V from the power supplies). As the output voltage increases, however, the linear input range will be limited by the output voltage swing of the input amplifiers, A_1 and A_2 . The common-mode range is related to the output voltage of the complete amplifier—see performance curve "Input Common-Mode Range vs Output Voltage."

A combination of common-mode and differential input signals can cause the output of A_1 or A_2 to saturate. Figure 6 shows the output voltage swing of A_1 and A_2 expressed in terms of a common-mode and differential input voltages. Output swing capability of the input amplifiers, A_1 and A_2 is the same as the output amplifier, A_3 . For applications where input common-mode range must be maximized, limit the output voltage swing by connecting the INA115 in a lower gain (see performance curve "Input Common-Mode Voltage Range vs Output Voltage"). If necessary, add gain after the INA115 to increase the voltage swing.

Input-overload often produces an output voltage that appears normal. For example, an input voltage of +20V on one input and +40V on the other input will obviously exceed the linear

common-mode range of both input amplifiers. Since both input amplifiers are saturated to the nearly the same output voltage limit, the difference voltage measured by the output amplifier will be near zero. The output of the INA115 will be near 0V even though both inputs are overloaded.

INPUT PROTECTION

The inputs of the INA115 are individually protected for voltages up to ± 40 V. For example, a condition of -40V on one input and +40V on the other input will not cause damage. Internal circuitry on each input provides low series impedance under normal signal conditions. To provide equivalent protection, series input resistors would contribute excessive noise. If the input is overloaded, the protection circuitry limits the input current to a safe value (approximately 1.5mA). The typical performance curve "Input Bias Current vs Common-Mode Input Voltage" shows this input current limit behavior. The inputs are protected even if the power supply voltage is zero.

OTHER APPLICATIONS

See the INA114 data sheet for other applications circuits of general interest.

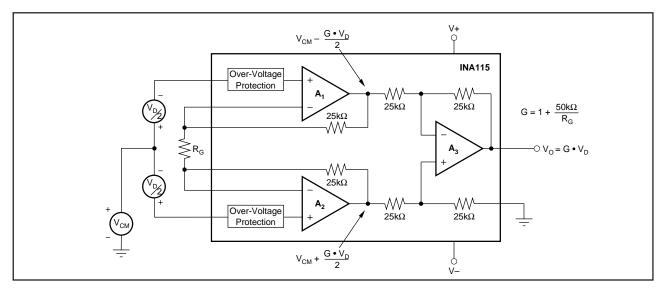


FIGURE 6. Voltage Swing of A₁ and A₂.

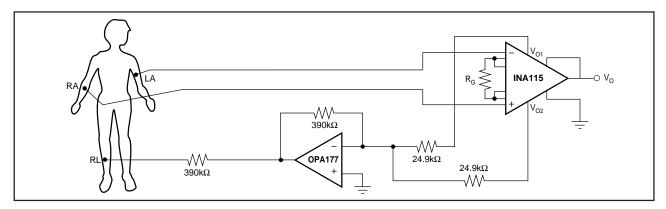


FIGURE 7. ECG Amplifier with Right Leg Drive.



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
INA115AU	ACTIVE	SOIC	DW	16	48	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
INA115AU/1K	ACTIVE	SOIC	DW	16	1000	Pb-Free (RoHS)	CU NIPDAU	Level-3-260C-168 HR
INA115AU/1KE4	ACTIVE	SOIC	DW	16	1000	Pb-Free (RoHS)	CU NIPDAU	Level-3-260C-168 HR
INA115BU	ACTIVE	SOIC	DW	16	48	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
INA115BUG4	ACTIVE	SOIC	DW	16	48	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD**: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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